

EQ
#1516
7-12-03

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

RECEIVED

JUL 11 2003

Technology Center 2600

In re patent application of

Hamid K. Aghajan

Group Art Unit: 2625

Serial No.: 09/365,517

Examiner: S. C. Chawan

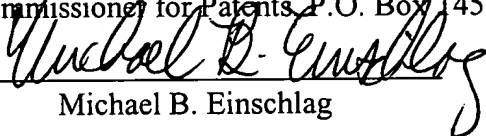
Filed: August 2, 1999

Date: July 3, 2003

For: Two-Dimensional Scatter Plot
Technique for Defect Detection

CERTIFICATE OF MAILING under 37 C.F.R. 1.8(a)

I hereby certify that this correspondence is being deposited on July 3, 2003 with the United States Postal Service as first class mail, with sufficient postage, in an envelope addressed to Commissioner for Patents, P.O. Box 1450, Alexandria, Virginia 22313-1450.


Michael B. Einschlag

July 3, 2003
Date of Signature

Commissioner for Patents
P.O. Box 1450
Alexandria, Virginia 22313-1450
Sir:

This is in response to an Office Action mailed March 26, 2003. An Extension Petition is attached to extend the time for filing by one (1) month to and including July 26, 2003.